

PATENT
2557-000158/US

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

A Applicants: Taek-Joon JEON et al.
Application No.: NEW APPLICATION
Filed: AUGUST 21, 2003
For: SEMICONDUCTOR TEST SYSTEM AND METHOD OF OPERATING
THE SAME

INFORMATION DISCLOSURE STATEMENT
(SUBMISSION CONCURRENT WITH THE
FILING OF A NEW PATENT APPLICATION)

August 21, 2003

MAIL STOP NEW APPLICATION
COMMISSIONER FOR PATENTS
P.O. BOX 1450
Alexandria, Virginia 22313-1450

Sir:

Pursuant to 37 C.F.R. §§ 1.97 and 1.98, applicant(s) hereby submit(s) an Information Disclosure Statement for consideration by the Examiner.

I. LIST OF PATENTS, PUBLICATIONS OR OTHER INFORMATION

The patents, publications, or other information submitted for consideration by the Office are listed on PTO-1449, attached hereto.

II. COPIES

- Submitted herewith is a legible copy of (i) each U.S. and foreign patent; (ii) each publication or that portion which caused it to be listed; and (iii) all other information or that portion which caused it to be listed.
- This application is a National Phase of a PCT application. Some or all of the documents listed on the PTO-1449 are not enclosed because they were cited in the International Search Report and copies should be forwarded from the International Search Authority. If copies are needed, please contact the undersigned.

III. **CONCISE EXPLANATION OF THE RELEVANCE**
(check at least one box)

a. **DOCUMENTS IN THE ENGLISH LANGUAGE**

The attached patents, publications, or other information in the English language do not require a statement of relevancy.

b. **DOCUMENTS NOT IN THE ENGLISH LANGUAGE**

A concise explanation of the relevance of all patents, publications, or other information listed that is not in the English language is as follows:

For the Examiner's convenience, Applicants submit herewith an English language Abstract for Korean Patent Application Nos. 1995-37825 and 1996-061594, and Japanese Patent Nos. JP9061491; and JP2001349927

c. **OTHER**

For the Examiner's convenience, we attach hereto U.S. Patent No. , which is the corresponding U.S. equivalent of . Submission of the English language equivalent(s) is deemed to satisfy the requirement for a concise explanation of relevancy.

FEES

This Information Disclosure Statement is being filed concurrently with the filing of a new patent application; therefore, no fee is required.

If The Examiner has any questions concerning this IDS, he/she is requested to contact the undersigned. If it is determined that this IDS has been filed under the wrong rule, the PTO is requested to consider this IDS under the proper rule and charge the appropriate fee to Deposit Account No. 08-0750.

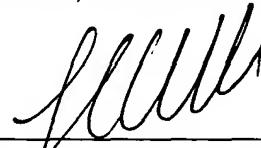
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If necessary, the Commissioner is hereby authorized in this, concurrent, and future replies, to charge payment or credit any overpayment to Deposit Account No. 08-0750 for any additional fees required under 37 C.F.R. § 1.16 or under § 1.17; particularly, extension of time fees.

Respectfully submitted,

HARNESS, DICKEY & PIERCE, P.L.C

By: _____


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Enclosures: Form PTO-1449(s)

Documents

Fee

Form PTO-1449 INFORMATION DISCLOSURE CITATION IN AN APPLICATION (Use several sheets if necessary)		ATTY DOCKET NO. 2557-000158/US	APPLICATION NO. NEW			
		APPLICANT Taek-Joon JEON et al.	CONF. NO. Unknown			
		FILING DATE August 21, 2003	GROUP Unknown			
U.S. PATENT DOCUMENTS						
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
FOREIGN PATENT DOCUMENTS						
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	TRANSLATION
						YES
	1995-37825	10/28/1995	Republic of Korea			ABST
	1996-061594	12/4/1996	Republic of Korea			ABST
	JP9061491	3/7/1997	Japan			ABST
	JP2001349927	12/21/2001	Japan			ABST
OTHER DOCUMENTS (Include Name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.) date, page(s), volume-issue number(s), publisher, city and/or country where published.)						
EXAMINER			DATE CONSIDERED			
EXAMINER: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.						